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APPLICATION NO.	F	ILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/832,272	04/10/2001		Kirk Prall	3969.3US (95-0310.3)	2827
24247	7590	08/28/2002			
TRASK B	RITT		EXAMINER		
P.O. BOX 2 SALT LAK		JT 84110	WARREN, MATTHEW E		
				ART UNIT	PAPER NUMBER
				2815	
			DATE MAILED: 08/28/2002		

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)	10				
	,	09/832,272	PRALL ET AL.	N				
	Office Action Summary	Examiner	Art Unit					
		Matthew E. Warren	2815					
	The MAILING DATE of this communication app	ears on the cover sheet w	vith the correspondence ad	dress				
Period fo		(10 05T TO EVEIDE a	HONTHO FROM					
THE I - External form of the control	ORTENED STATUTORY PERIOD FOR REPL' MAILING DATE OF THIS COMMUNICATION. nsions of time may be available under the provisions of 37 CFR 1.1: SIX (6) MONTHS from the mailing date of this communication. period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period v re to reply within the set or extended period for reply will, by statute eply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a within the statutory minimum of th will apply and will expire SIX (6) MC cause the application to become	reply be timely filed irty (30) days will be considered timely INTHS from the mailing date of this co ABANDONED (35 U.S.C. § 133).	mmunication.				
Status	m in the committee of the decidence of t	Any 2002						
1) 🖾	Responsive to communication(s) filed on <u>17 I</u>							
2a)⊠	•	is action is non-final.	attern proposition of to th	o morito io				
3)∐	3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
Disposit	ion of Claims	•						
	Claim(s) 1-42 is/are pending in the application							
	4a) Of the above claim(s) is/are withdraw	wn from consideration.						
5) 🔲	Claim(s) is/are allowed.							
6)⊠	☑ Claim(s) <u>1-42</u> is/are rejected.							
7)	Claim(s) is/are objected to.							
-	Claim(s) are subject to restriction and/o	r election requirement.						
	ion Papers							
•	The specification is objected to by the Examine		the Everines					
10)∐	The drawing(s) filed on is/are: a)☐ acce							
44)[7]	Applicant may not request that any objection to the		disapproved by the Examin	er				
11)	The proposed drawing correction filed on If approved, corrected drawings are required in re		alouppiotod by the Examin					
12\□	The oath or declaration is objected to by the Ex							
•	under 35 U.S.C. §§ 119 and 120							
	Acknowledgment is made of a claim for foreign	n priority under 35 U.S.C	:. § 119(a)-(d) or (f).					
•	☐ All b)☐ Some * c)☐ None of:	, p	• (, (,)					
a)	<u> </u>	s have been received.						
	 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 							
* :	Copies of the certified copies of the prior application from the International Buse the attached detailed Office action for a list	rity documents have bee reau (PCT Rule 17.2(a)	en received in this National	Stage				
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).								
	a) 🗍 The translation of the foreign language pro	ovisional application has	been received.					
15)	Acknowledgment is made of a claim for domes	ic priority under 35 U.S.	C. §§ 120 and/or 121.					
Attachmer		🗖	OTO 440\ D	(-)				
2) Notice	ce of References Cited (PTO-892) ce of Draftsperson's Patent Drawing Review (PTO-948) rmation Disclosure Statement(s) (PTO-1449) Paper No(s) <u>&</u>	5) Notice	w Summary (PTO-413) Paper No of Informal Patent Application (PT					

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DETAILED ACTION

This Office Action is in response to the Amendment filed on May 17, 2002.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-42 are rejected under 35 U.S.C. 103(a) as being unpatentable over Aoki et al. (US 5,629,539) in view of Iacoponi (US 5,545,592).

Aoki et al. shows (fig. 1b) a dynamic random access memory array (DRAM) comprising a substrate (10), a plurality of memory cells, each cell having field effect access transistors and a stacked capacitor (21b, 27, and 28). The field effect transistors have source/drain regions (15b) that function as storage node junctions and are connected to the capacitor of the memory cell. The transistors also have second source/drain regions (15a) which functions as an access node junction and an insulated gate (13) overlying the substrate. The gate is insulated from the substrate by a gate dielectric (12) of silicon oxide and has vertical sidewalls (16) and an upper surface which are both covered by a dielectric of nitride (14). The gate electrode (13) comprises doped polysilicon. Along the length of the substrate, other access transistors are insulated from the substrate by a field oxide region (11). An interlevel dielectric layer (31) comprising a second dielectric material is blanketed over the substrate to a level

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above the capacitors. A plurality of digit line contact openings (having 21a and 24a) penetrate the interlevel dielectric layer and terminate at an access node junction (15a). The contact opening is self-aligned with the first dielectric material of the sidewall insulation of the gate because the contact is adjacent to the gate. The contact opening may be filled with a layered structure including tungsten and titanium (col. 8, lines 40-46) A digit line (33) is formed on top of the interlevel dielectric layer and makes electrical contact to the tungsten plug. Aoki shows all of the elements of the claims except the digit line contact opening having the specific titanium and CVD TiN and tungsten layer formed on the access node junction. Iacaponi shows (figs. 7) a contact structure comprising a contact opening formed in an interlayer dielectric layer (130). An access node junction (in silicon material 100) has a layer of titanium silicide (120) formed on it. A layer of titanium (150) is formed on the sidewalls of the opening. A CVD titanium nitride layer (160) and CVD tungsten (170) are subsequently deposited to fill the openings (col. 1, line 60 - col. 2, line 4). The silicide layer is formed by reacting the titanium with the source/drain region (col.1, lines 32-34). As can be seen from the figure, the titanium layer is overlying the silicide layer by does not make contact with the tungsten layer. The titanium/titanium nitride combination in conjunction with the silicide layer provides a low resistance electrical contact while the TiN provides a diffusion barrier for the underlying Ti layer and an adhesion promoter for the W layer (col. 1, lines 57 - col. 2, line 4). Therefore it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the contact opening of Aoki by adding a titanium metal layer and silicide to the access node junction of a transistor because

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lacoponi teaches that such a configuration provides a low resistance electrical connection and adhesion promotion of tungsten.

With respect to the limitations of the CVD (chemical vapor deposited) titanium and tungsten and the reaction of titanium with silicon to form silicide, a "product by process" claim is directed to the product per se, no matter how actually made, In re Hirao, 190 USPQ 15 at 17(footnote 3). See also in re Brown, 173 USPQ 685: In re Luck, 177 USPQ 523; In re Fessmann, 180 USPQ 324: In re Avery, 186 USPQ 116 in re Wertheim, 191 USPQ 90 (209 USPQ 254 does not deal with this issue); and In re Marosi et al, 218 USPQ 289 final product per se which must be determined in a "product by, all of" claim, and not the patentability of the process, and that an old or obvious product, whether claimed in "product by process" claims or not. Note that Applicant has the burden of proof in such cases, as the above case law makes clear. "Even though product-by- process claims are limited by and defined by the process, determination of patentability is based upon the product itself. The patentability of a product does not depend on its method of production. If the product in product-byprocess claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product is made by a different process." In re Thorpe, 227 USPQ 964, 966 (Fed. Cir. 1985)(citations omitted).

Response to Arguments

Applicant's arguments with respect to claims 1-42 have been considered but are moot in view of the new ground(s) of rejection.

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Conclusion

Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Matthew E. Warren whose telephone number is (703) 305-0760. The examiner can normally be reached on Mon-Thurs, and alternating Fri, 9:00-5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie Lee can be reached on (703) 308-1690. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 305-3432 for regular communications and (703) 308-7722 for After Final communications.

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Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

MEW *MEW*August 22, 2002

SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800